

Notice of References Cited	Application/Control No. 09/620,563	Applicant(s)/Patent Under Reexamination MARTIN ET AL.	
	Examiner Scott L. Jarrett	Art Unit 3623	Page 1 of 3

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	Examiner Scott L. Jarrett	Art Unit 3623	Page 2 of 3

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	Examiner Scott L. Jarrett	Art Unit 3623	Page 3 of 3

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